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CMC for the field of measured quantity: Testing of properties and defects of materials

Ord.	Calibrated quantity / Subject of calibration	Nom	inal ra	ange		Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty	Calibration principle	Calibration procedure	Work
ber ¹		min. unit		max.	unit		specified ²		identification ³	place
1*	Ultrasonic defectoscopes								A 04-55/31	
	Stability – measurement of amplitude							Signal generation by reference generator		
		0 % SH	to	100 9	6 SH		1.4 % SH	(ČSN EN 12668-1:2010)		
	Stability - measurement of position	0 % SW	to	100 9	6 SW		1.1 % SW			
	Transmitter - Impulse voltage amplitude							Direct signal measurement with a reference		
		1 V	to	400 V	1		3.2 %	oscilloscope (ČSN EN 12668-1:2010)		
	Transmitter – Pulse decay amplitude	1 V	to	400 V	1		3.2 %			
	Transmitter – Pulse rise time	0 ns	to	500 n	IS		2.7 % + 2.4 ns			
	Transmitter – Pulse duration	0 ns	to	500 n	IS		2.7 % + 2.4 ns			
	Receiver $ f_{lm}$, lower limit frequency							Signal generation by a reference generator		
		0.1 MHz	to	25 N	ИHz		3.3 %	(ČSN EN 12668-1:2010)		
	Receiver – fum, upper limit frequency	0.1 MHz	to	25 N	ИHz		3.3 %			
	Receiver – f0, medium frequency	0.1 MHz	to	25 N	ИHz		3.5 %			
	Receiver – Δf , bandwidth	0.1 MHz	to	25 N	ИHz		4.7 %			
	Receiver – Equivalent input noise level							Direct signal measurement with a reference oscilloscope, Comparison with a reference attenuator		
		$10^{-12} \text{ V/}\sqrt{\text{Hz}}$	to	10 ⁻⁶ V	//√Hz		2.7·10 ⁻⁹ V/√Hz	(ČSN EN 12668-1:2010)		

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Ord.	Calibrated quantity / Subject of calibration	Non	ninal 1	ange		Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	Calibration procedure identification ³	Work
ber ¹		min. unit		max.	unit					place
	Receiver – Attenuator accuracy							Comparison with a		
		0.10		70.11			2.0.0/ . 0.2.1D	reference attenuator		
	Descion West of Process	0 dB	to	70 dl	_		2.8 % + 0.2 dB	(ČSN EN 12668-1:2010)		
	Receiver – Vertical linearity	0 dB	to	70 dl	В		2.8 % + 0.2 dB	G' 1 1		
	Time base linearity for digital instruments							Signal generation by reference generator		
	mstruments	0.5 μs	to	2,000 με	S		$1.1 \% + 0.05 \mu s$	(ČSN EN 12668-1:2010)		
2*	Ultrasonic thickness gauges	0.00 pts		_, p			212 70 1 0100 µ0	(000, 20, 2000 0,2000)	A 04-55/01	
	Low voltage warning							Direct measurement of		
								voltage and current with a		
		1 17		20.11			0.07.0/	reference multimeter		
	X 1.	1 V	to	20 V			0.87 %	(ČSN EN 15317)		
	Voltage operating range	1 V	to	20 V			0.87 %			
	Current operating range	20 mA	to	2,000 m	Α		0.43 %	D' ' 1		
	Transmitter – Pulse repeating period							Direct signal measurement with a reference		
								oscilloscope		
		0.1 ms	to	10 m	ıs		0.50 %	(ČSN EN 15317)		
	Transmitter – Impulse voltage amplitude	1 V	to	400 V			3.2 %	•		
	Transmitter – Pulse decay amplitude	1 V	to	400 V			3.2 %			
	Transmitter – Pulse rise time	0 ns	to	500 ns	3		2.7 % + 2.4 ns			
	Transmitter – Pulse duration	0 ns	to	500 ns	3		2.7 % + 2.4 ns			
	Min. and max. measurable thickness							Comparison with a length		
		1 mm	to	100 m	m		0.04 mm	standard (ČSN EN 15317)		
	Thickness resolution			0.1 m	m	th. (9.4 to 9.8) mm	0.04 mm			

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Ord.	Calibrated quantity / Subject of calibration	Non	ninal 1	range	Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	Calibration procedure identification ³	Work place
ber ¹		min. unit		max. unit					
3*	Tangential magnetic field / Hand magnets	1.5 kA/m	to	15 kA/m	50 Hz	7.7 %	Measurement by a teslameter (ČSN EN ISO 9934-3)	A 04-53/41a	
4*	AC current / Current generators	0 A	to	2,000 A	50 Hz	4.9 % + 8 A	Comparison with a clamp ammeter (ČSN EN ISO 9934-3)	A 04-53/51a	
5*	Stationary magnetization equipment							A 04-53/61a	
	Tangential magnetic field	2 kA/m	to	6 kA/m	50 Hz	7.7 %	Measurement by a teslameter (ČSN EN ISO 9934-3)		
	AC current	0 A	to	2,000 A	50 Hz	4.9 % + 8 A	Comparison with a clamp ammeter (ČSN EN ISO 9934-3)		
6*	Meters of magnetic field intensity (teslameters, gaussmeters, magnetometers)							A 04-53/32	
	DC tangential magnetic field						Comparison with coil magnetic induction standard		
		0.5 kA/m	to	1.5 kA/m		2.0 %	(ČSN EN ISO 9934-3)		
	AC tangential magnetic field	0.5 kA/m	to	1.5 kA/m	50 Hz	3.0 %			
	DC tangential magnetic field	1.5 kA/m	to	30 kA/m	50.11	0.8 %			
	AC tangential magnetic field	1.5 kA/m	to	30 kA/m	50 Hz	1.2 %			

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Ord.	Calibrated quantity / Subject of calibration		Nomi	inal ra	ange		Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	Calibration procedure identification ³	Work place
ber ¹			unit		max.	unit					
7*	Eddy current defectoscopes									A 04-51/29	
	Generator frequency	0.1.1.1	-		1 000 1	**		0.011.0	Direct signal measurement with a reference counter		
	Receiver – f _{lm} , lower limit frequency	0.1 kF		to	1,000 k			0.011 %	(ČSN EN 15548-1:2010) Signal generation by a reference generator		
		1 kF		to	100 k			2.4 %	(ČSN EN ISO 15548-1)		
	Receiver – f _{um} , upper limit frequency	1 kF		to	100 k			2.4 %			
	Receiver $-f_0$, medium frequency	1 kF		to	100 k			2.5 %			
	Receiver – Δf , bandwidth	1 kF	I z	to	100 k	кHz		5.7 %			
	Receiver - attenuator accuracy								Comparison with a		
		0 dE	3	to	30 d	lB	1 kHz to 100 kHz	0.43 dB	reference attenuator (ČSN EN ISO 15548-1)		
8*	Digital ultrasonic defectoscopes									A 04-55/21	
	Transmitter – Impulse voltage amplitude								Direct signal measurement with a reference oscilloscope		
		1 V		to	400 V	V		3.2 %	(ČSN EN ISO 22232-1)		
	Transmitter – Pulse rise time	0 ns		to	500 r	ıs		2.7 % + 2.4 ns			
	Transmitter – Pulse duration	0 ns		to	500 r	ıs		2.7 % + 2.4 ns			
	Receiver – flm, lower limit frequency								Signal generation by a reference generator		
		0.1 M	Hz	to	25 N	МHz		3.3 %	(ČSN EN ISO 22232-1)		
	Receiver – fum, upper limit frequency	0.1 M	Hz	to	25 N	МHz		3.3 %			
	Receiver – f0, medium frequency	0.1 M	Hz	to	25 N	ИHz		3.5 %			
	Receiver – Δf , bandwidth	0.1 M	Hz	to	25 N	ИHz		4.7 %			

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Ord.	Calibrated quantity / Subject of calibration		Nominal	range	Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	procedure	Work
ber ¹	<u> </u>	min. ur	nit	max. unit					place
	Receiver – noise level	10.10.14		10 61/1		2.7.10.0.1//	Direct signal measurement with a reference oscilloscope, Comparison with a reference attenuator		
	Receiver – gain linearity	10-12 V/√	Hz to	10-6 V/√Hz		2.7·10-9 V/√Hz	(ČSN EN ISO 22232-1) Comparison with a reference attenuator		
		0 dB	to	70 dB		2.8 % + 0.2 dB	(ČSN EN ISO 22232-1)		
	Receiver – display vertical linearity	0 dB	to	70 dB		2.8 % + 0.2 dB			
	Time base deviation						Signal generation by a reference generator		
		0.5 µs	to	2,000 μs		$1.1 \% + 0.05 \mu s$	(ČSN EN ISO 22232-1)		

Asterisk at the ordinal number identifies the calibrations, which the Laboratory is qualified to carry out outside the permanent laboratory premises.

Explanatory notes:

SW Screen Width

SH Screen Height

The expanded measurement uncertainty is in accordance with ILAC-P14 and EA-4/02 M part of CMC, and it is the lowest value of the respective uncertainty. If not stated otherwise, its coverage probability is approx. 95 %. If not stated otherwise, the uncertainty values stated without a unit are relative to the value measured. The uncertainty value stated herein is based on the best conditions achievable by the laboratory; the uncertainty value of a specific calibration may be higher, depending on the conditions of such a calibration. For identical extreme values of adjacent ranges, the lower uncertainty value always applies.

³ If the document identifying the calibration procedure is dated, only these specific procedures are used. If the document identifying the calibration procedure is not dated, the latest edition of the specified procedure is used (including any changes).